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CC-284

M. Sc. EXAMINATION, May 2018

(Third Semester)

(Re-appear Only)

PHYSICS

PHY607B

Characterization of Materials

Time: 3 Hours [Maximum Marks: 100

Before answering the question-paper candidates should ensure that they have been supplied to correct and complete question-paper. No complaint, in this regard, will be entertained after the examination.

Note: Attempt *Five* questions in all, selecting at least *one* question from each Unit. All questions carry equal marks.

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P.T.O.

Unit I

- 1. (a) What is the basic principle of X-ray topographic technique? Explain it with neat diagrams.
 - (b) Explain Lang technique for recording X-ray topography.10,10
- **2.** Write in detail:
 - (a) Double crystal diffractometry
 - (b) Neutron scattering with reference to light elements. 10,10

Unit II

- 3. Explain the instrumentation and working of scanning electron microscope.20
- **4.** Write notes on the following technique:
 - (a) RBS
 - (b) SIMS. **20**

Unit III

5. Explain the following:

- 20
- (a) Double beam IR spectrometer with a ray diagram
- (b) Optic and acoustic modes in solids.
- 6. Write the experimental study of Raman effect.Discuss classical of Raman effect and also its applications.10,10

Unit IV

- Discuss Mossbauer spectroscopy with explaining the terms, recoil and thermal energies of a nucleus.
- **8.** (a) Write a short note on Microwave Spectroscopy.
 - (b) Discuss the experimental technique of ESR spectroscopy. 10,10

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